

TPL7407LA-Q1 30V 7 通道低侧驱动器

1 特性

- 符合汽车类应用的标准
- 具有符合 AEC-Q100 标准的下列结果：
 - 器件温度 1 级：-40°C 至 +125°C 的环境运行温度范围
 - 器件 HBM ESD 分类等级 2
 - 器件 CDM ESD 分类等级 C4B
- 600mA 额定漏极电流（每通道）
- 7 通道达林顿晶体管阵列 CMOS 引脚对引脚改善（例如：ULN2003A）
- 能效（极低 V_{OL} ）
 - 电流为 100mA 时， V_{OL} 低于达林顿晶体管阵列的四分之一
- 输出泄露极低，每通道小于 10nA
- 高压输出 30V
- 与 1.8V 和 5V 微控制器和逻辑接口兼容
- 用于提供电感反冲保护的内部自振荡二极管
- 可借助输入下拉电阻器实现三态输入驱动器
- 用来消除嘈杂环境中的杂散运行的输入 RC 缓冲器
- ESD 保护性能超出 JESD 22 标准
 - 2kV HBM, 500V CDM

2 应用

- 电感负载
 - 继电器
 - 单极步进电机和刷式直流电机
 - 电磁阀
- LED
- 逻辑电平位移
- 栅极和 IGBT 驱动

3 说明

TPL7407LA-Q1 是一款高压、高电流 NMOS 晶体管阵列。这个器件包含 7 个具有高压输出的 NMOS 晶体管，这些晶体管具有针对开关电感负载的共阴极钳位二极管。单个 NMOS 通道的最大漏极电流额定值为 600mA。器件添加了新的调节和驱动电路，可在全部 GPIO 范围（1.8V 至 5V）提供最大驱动能力。这些晶体管还可以通过采用并联方式来提供更高的电流。

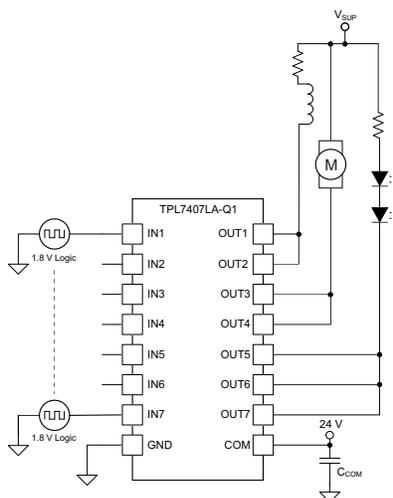
相比双极达林顿晶体管实施，TPL7407LA-Q1 的主要优势在于其具有更高的能效和更低的泄露。依赖于较低的 V_{OL} ，功率耗散比传统继电器驱动器减少一半，每通道的电流低于 250mA。

器件信息⁽¹⁾

器件号	封装（引脚）	封装尺寸（标称值）
TPL7407LA-Q1	TSSOP (16)	5.00mm × 4.40mm

(1) 如需了解所有可用封装，请参阅产品说明书末尾的可订购产品附录。

简化应用原理图



目录

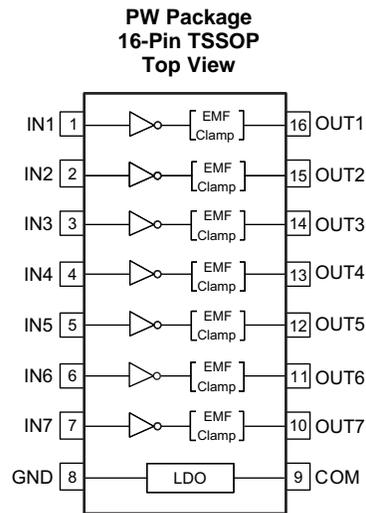
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4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

日期	修订版本	说明
2018 年 5 月	*	最初发布版本。

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
COM	9	—	Supply pin that must be tied to 6.5 V or higher for proper operation (see the Power Supply Recommendations section for more information)
GND	8	—	Ground pin
IN(X)	1	I	GPIO inputs that drives the outputs "low" (or sink current) when driven "high"
	2		
	3		
	4		
	5		
	6		
	7		
OUT(X)	10	O	Driver output that sinks currents after input is driven "high"
	11		
	12		
	13		
	14		
	15		
	16		

6 Specifications

6.1 Absolute Maximum Ratings

 at 25°C free-air temperature (unless otherwise noted) ⁽¹⁾

		MIN	MAX	UNIT
V _{OUT}	Pins OUT1-OUT7 to GND voltage	-0.3	32	V
V _{OK}	Output clamp diode reverse voltage ⁽²⁾	-0.3	32	V
V _{COM}	COM pin voltage ⁽²⁾	-0.3	32	V
V _{IN}	Pins IN1-IN7 to GND voltage ⁽²⁾	-0.3	30	V
I _{DS}	Continuous drain current per channel ^{(3) (4)}		600	mA
I _{OK}	Output clamp current		500	mA
I _{GND}	Total continuous GND-pin current		-2	A
T _J	Operating virtual junction temperature	-40	150	°C
T _{stg}	Storage temperature	-65	150	°C

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to the GND/substrate pin, unless otherwise noted.
- (3) Maximum power dissipation is a function of T_{J(max)}, θ_{JA}, and T_A. The maximum allowable power dissipation at any allowable ambient temperature is P_D = (T_{J(max)} - T_A)/θ_{JA}. Operating at the absolute maximum T_J of 150°C can affect reliability.
- (4) The package thermal impedance is calculated in accordance with JESD 51-7.

6.2 ESD Ratings

		VALUE	UNIT	
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	±2000	
		Charged-device model (CDM), per AEC Q100-011	All pins	±500
			Corner pins (1, 8, 9, 16)	±750

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

Over operating temperature range

		MIN	MAX	UNIT
V _{OUT}	OUT1 – OUT7 pin voltage for recommended operation	0	30	V
V _{COM}	COM pin voltage range for full output drive	6.5	30	V
V _{IL}	IN1- IN7 input low voltage ("Off" high impedance output)		0.9	V
V _{IH}	IN1- IN7 input high voltage ("Full Drive" low impedance output)	1.5		V
T _A	Operating free-air temperature	-40	125	°C
I _{DS}	Continuous drain current	0	500	mA

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TPL7407LA-Q1	UNIT
		TSSOP (PW)	
		16 PINS	
θ _{JA}	Junction-to-ambient thermal resistance	113.1	°C/W
θ _{JCtop}	Junction-to-case (top) thermal resistance	46.5	°C/W
θ _{JB}	Junction-to-board thermal resistance	58.6	°C/W
ψ _{JT}	Junction-to-top characterization parameter	7	°C/W
ψ _{JB}	Junction-to-board characterization parameter	58	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

 $T_J = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$; Typical Values at $T_A = 25^{\circ}\text{C}$ ⁽¹⁾

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{OL} (V_{DS})	OUT1- OUT7 low-level output voltage	$V_{IN} \geq 1.5\text{ V}$	$I_D = 100\text{ mA}$		210	450	mV
			$I_D = 200\text{ mA}$		430	900	
V_{IL}	IN1- IN7 low-level input voltage	$I_D = 5\text{ }\mu\text{A}$				0.9	V
V_{IH}	IN1- IN7 high-level input voltage	$I_D = 100\text{ mA}$		1.5			V
$I_{OUT(OFF)}$ (I_{DS_OFF})	OUT1- OUT7 OFF-state leakage current	$V_{OUT} = 30\text{ V}$, $V_{IN} \leq 0.9\text{ V}$			10	500	nA
V_F	Clamp forward voltage	$I_F = 200\text{ mA}$				1.4	V
$I_{IN(off)}$	IN1- IN7 Off-state input current	$V_{INX} = 0\text{ V}$	$V_{OUT} = 30\text{ V}$			500	nA
$I_{IN(ON)}$	IN1- IN7 ON state input current	$V_{INX} = 1.5\text{ V} - 5\text{ V}$				10	μA
I_{COM}	Static current flowing through COM pin	$V_{COM} = 6.5\text{ V} - 30\text{ V}$			17	30	μA

(1) During production testing, device is tested under short duration, therefore $T_A = T_J$.

6.6 Switching Characteristics

Typical Values at $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{PLH}	Propagation delay time, low- to high-level output	$V_{INX} \geq 1.65\text{ V}$, $V_{pull-up} = 30\text{ V}$, $R_{pull-up} = 48\text{ }\Omega$			350		ns
t_{PHL}	Propagation delay time, high- to low-level output	$V_{INX} \geq 1.65\text{ V}$, $V_{pull-up} = 30\text{ V}$, $R_{pull-up} = 48\text{ }\Omega$			350		ns
C_i	Input capacitance	$V_i = 0$,	$f = 100\text{ kHz}$		5		pF

6.7 Typical Characteristics

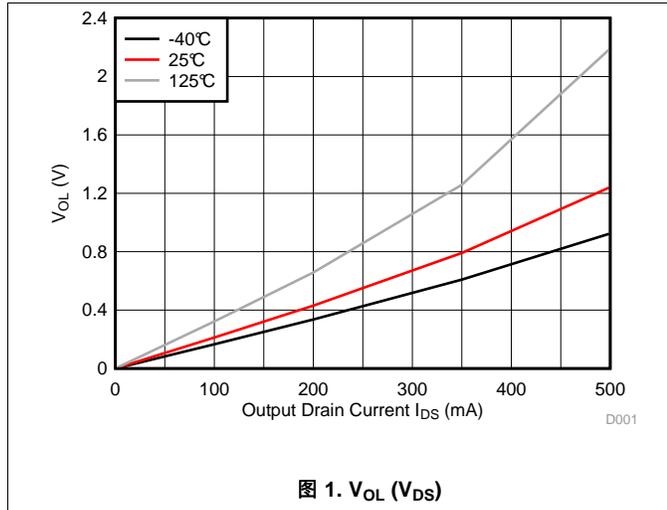


图 1. V_{OL} (V_{DS})

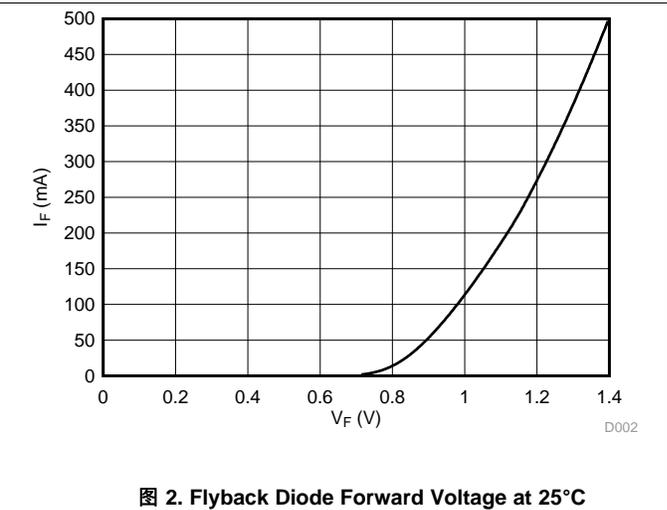


图 2. Flyback Diode Forward Voltage at 25°C

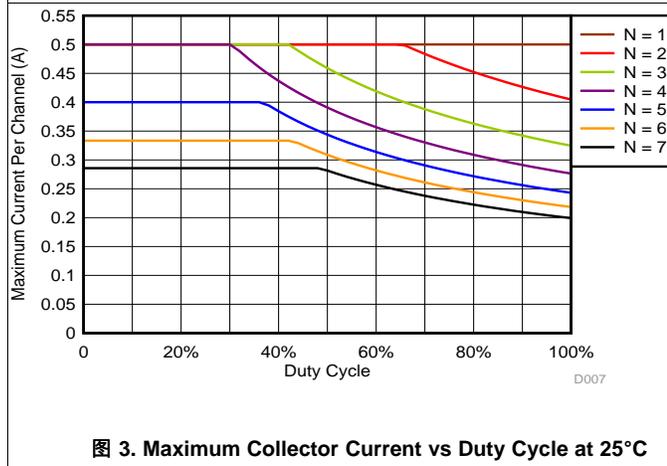


图 3. Maximum Collector Current vs Duty Cycle at 25°C

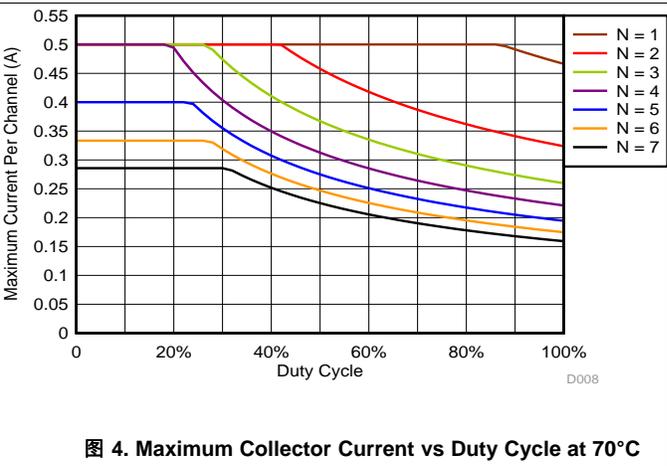


图 4. Maximum Collector Current vs Duty Cycle at 70°C

7 Detailed Description

7.1 Overview

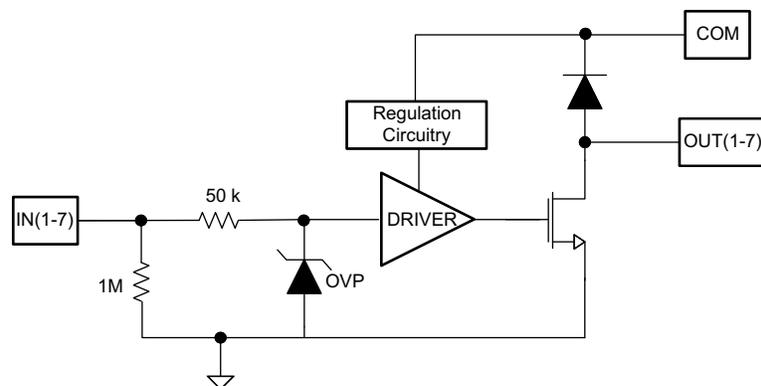
The TPL740LA-Q1 integrates seven low side NMOS transistors that are capable of sinking up to 600 mA and wide GPIO range capability.

The TPL7407LA-Q1 comprises seven high voltage, high current NMOS transistors tied to a common ground driven by internal level shifting and gate drive circuitry. The TPL7407LA-Q1 offers solutions to many interface needs, including solenoids, relays, lamps, small motors, and LEDs. Applications requiring sink currents beyond the capability of a single output may be accommodated by paralleling the outputs.

The TPL7407LA-Q1 also enables pin to pin replacement with legacy 7 channel darlington pair implementations.

This device can operate over a wide temperature range (–40°C to +125°C).

7.2 Functional Block Diagram



7.3 Feature Description

Each channel of the TPL7407LA-Q1 consists of high power low side NMOS transistors driven by level shifting and gate driving circuitry. The gate drivers allow for high output current drive with a very low input voltage, meaning full operation with low GPIO voltages.

In order to enable floating inputs a 1-MΩ pull-down resistor exists on each channel. Another 50-kΩ resistor exists between the input and gate driving circuitry. This exists to limit the input current whenever there is an over voltage and the internal Zener clamps. It also interacts with the inherent capacitance of the gate driving circuitry to behave as an RC snubber to help prevent spurious switching in noisy environment.

In order to power the gate driving circuitry an LDO exists. See the [Power Supply Recommendations](#) section for further detail on this circuitry.

The diodes connected between the output and COM pin is used to suppress kick-back voltage from an inductive load that is excited when the NMOS drivers are turned off (stop sinking) and the stored energy in the coils causes a reverse current to flow into the coil supply.

7.4 Device Functional Modes

7.4.1 Inductive Load Drive

When the COM pin is tied to the coil supply voltage, the TPL7407LA-Q1 is able to drive inductive loads and suppress the kick-back voltage via the internal free wheeling diodes.

7.4.2 Resistive Load Drive

When driving a resistive load, a pull-up resistor is needed in order for the TPL7407LA-Q1 to sink current and for there to be a logic high level. The COM pin must be supplied ≥ 6.5 V for full functionality.

Device Functional Modes (接下页)

7.4.3 ON State Input Current

The current into the INx pins is defined in the electrical characteristics table for input voltages from 1.5 V to 5 V. At higher voltages, this leakage increases, and the input current can be estimated using the approximate clamp voltage for the OVP diode, 6.4 V. [公式 1](#) shows how to approximate input current for input voltages greater than 6.4 V:

$$I_{IN(ON)} = V_{IN} / 1 \text{ M}\Omega + (V_{IN} - 6.4 \text{ V}) / 50 \text{ k}\Omega$$

where

- V_{IN} is the input voltage
- 1 M Ω is the input pull-down resistance
- 50 k Ω is the input series resistance
- 6.8 V is the approximate clamp voltage for the OVP diode

(1)

8 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The TPL7407LA-Q1 is typically used to drive a high voltage and/or current peripheral from an MCU or logic device that cannot tolerate these conditions. The following design is a common application of the TPL7407LA-Q1, driving inductive loads. This includes motors, solenoids and relays. Each load type can be modeled by what's seen in 图 7.

8.1.1 Unipolar Stepper Motor Driver

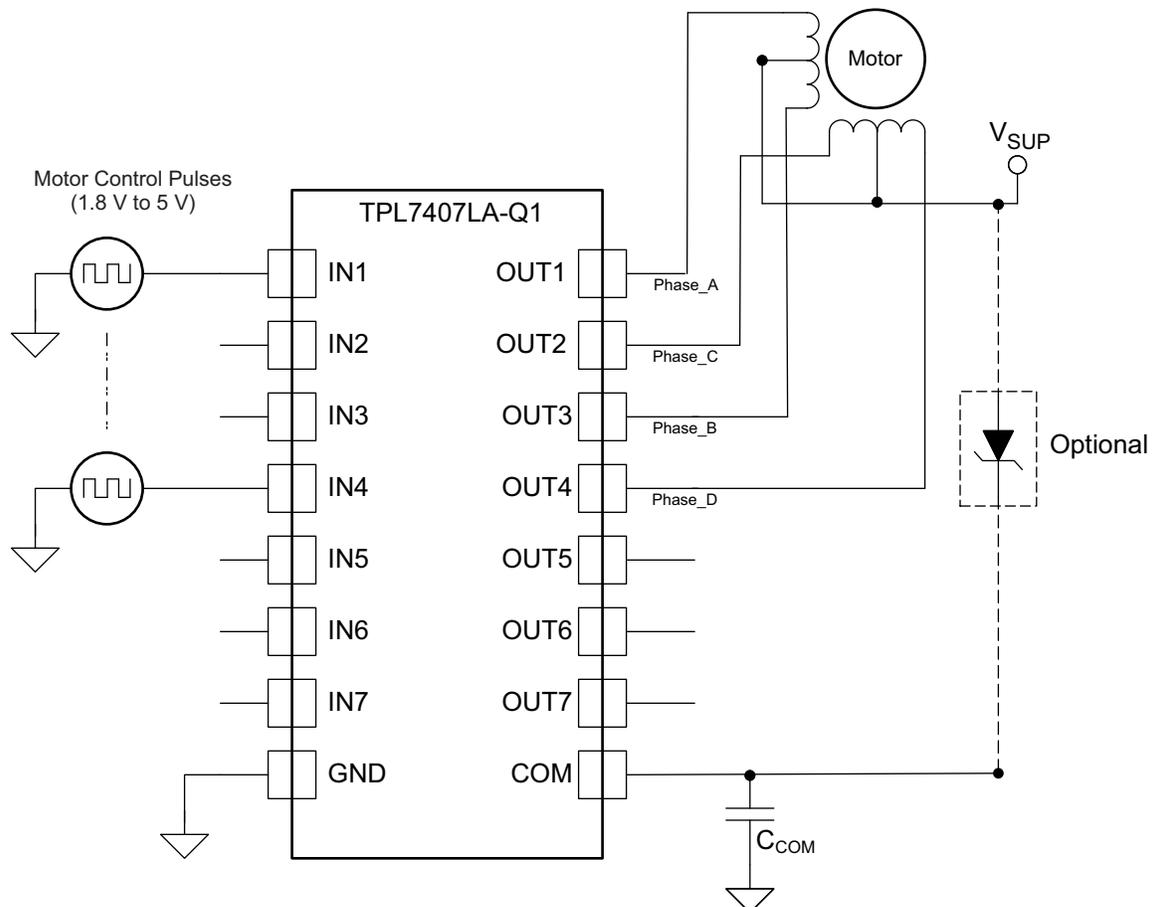
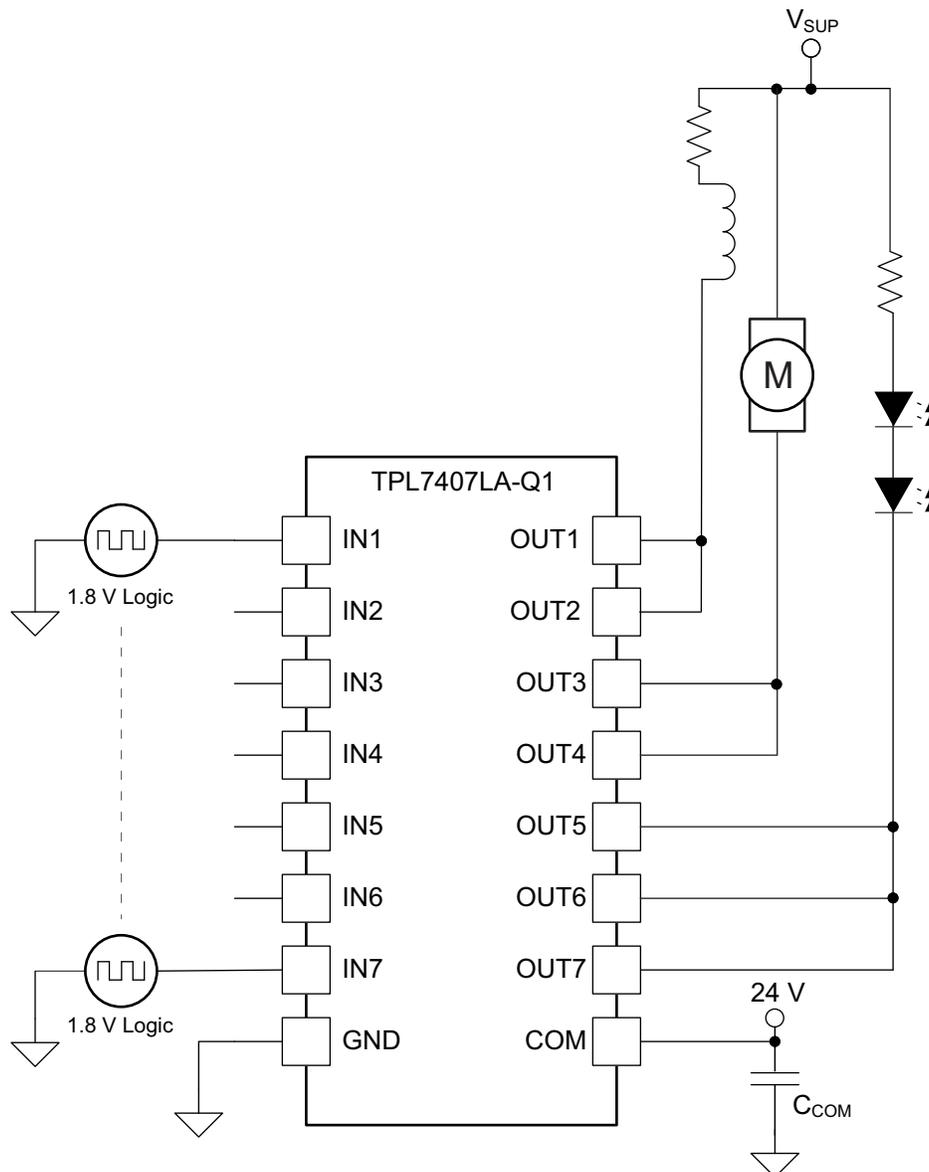


图 5. Stepper Motor Driver Schematic

图 5 shows an implementation of the TPL7407LA-Q1 for driving a unipolar stepper motor. The unconnected input channels can be used for other functions. When an input pin is left open the internal 1-M Ω pull down resistor pulls the respective input pin to GND potential. For higher noise immunity use an external short across an unconnected input and GND pins. The COM pin must be tied to the supply of whichever inductive load is being driven for the driver to be protected by the free-wheeling diode.

For more information on this application, see the [Stepper Motor Driving With Peripheral Drivers \(Driver ICs\)](#) application report.

Application Information (接下页)
8.1.2 Multi-Purpose Sink Driver

图 6. Multi-Purpose Sink Driver Schematic

When configured as per [图 6](#), the TPL7407LA-Q1 may be used as a multi-purpose driver. The output channels may be tied together to sink more current. The TPL7407LA-Q1 can easily drive motors, relays and LEDs with little power dissipation. COM must be tied to highest load voltage, which may or may not be same as inductive load supply.

8.2 Typical Application

A common application for the TPL7407LA-Q1 is driving inductive loads such as relays, solenoids, and unipolar stepper motors.

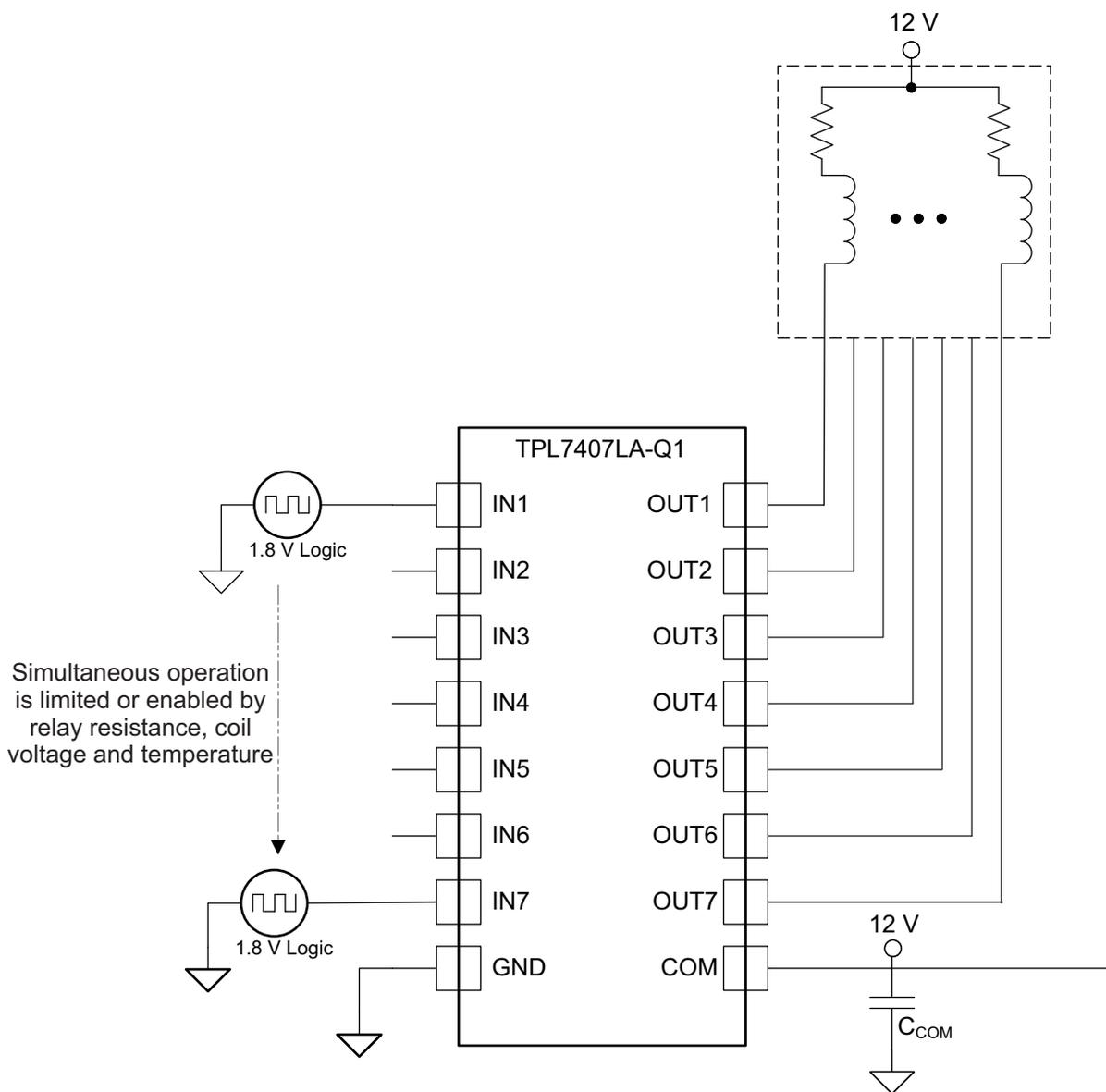


图 7. Inductive Load Driver Schematic

Typical Application (接下页)

8.2.1 Design Requirements

For this design example, use the parameters listed in [表 1](#) as the input parameters.

表 1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
GPIO Voltage	1.8 V, 3.3 V or 5 V
Coil supply voltage	6.5 V to 30 V
Number of channels	7
Output current (R_{COIL})	20 mA to 300 mA per channel
C_{COM}	0.1 μ F
Duty cycle	100%

8.2.2 Detailed Design Procedure

When using the TPL7407LA-Q1 in a coil driving application, determine the following:

- Input Voltage Range
- Temperature Range
- Output & Drive Current
- Power Dissipation

8.2.2.1 TTL and other Logic Inputs

The TPL7407LA-Q1 input interface is specified for standard 1.8 V through 5 V CMOS logic interface and can tolerate up to 30 V. At any input voltage the output drivers is going to be driven at its maximum when V_{COM} is greater than or equal to 6.5 V.

8.2.2.2 Input RC Snubber

The TPL7407LA-Q1 features an input RC snubber that helps prevent spurious switching in noisy environments. Connect an external 1 k Ω to 5 k Ω resistor in series with the input to further enhance the TPL7407LA-Q1's noise tolerance.

8.2.2.3 High-Impedance Input Drivers

The TPL7407LA-Q1 features a 1-M Ω input pull-down resistor. The presence of this resistor allows the input drivers to be tri-stated. When a high-impedance driver is connected to a channel input the TPL7407LA-Q1 detects the channel input as a low level input and remains in the OFF position. The input RC snubber helps improve noise tolerance when input drivers are in the high-impedance state.

8.2.2.4 Drive Current

The coil current is determined by the coil voltage (V_{SUP}), coil resistance & output low voltage (V_{OL}) as shown in [公式 2](#).

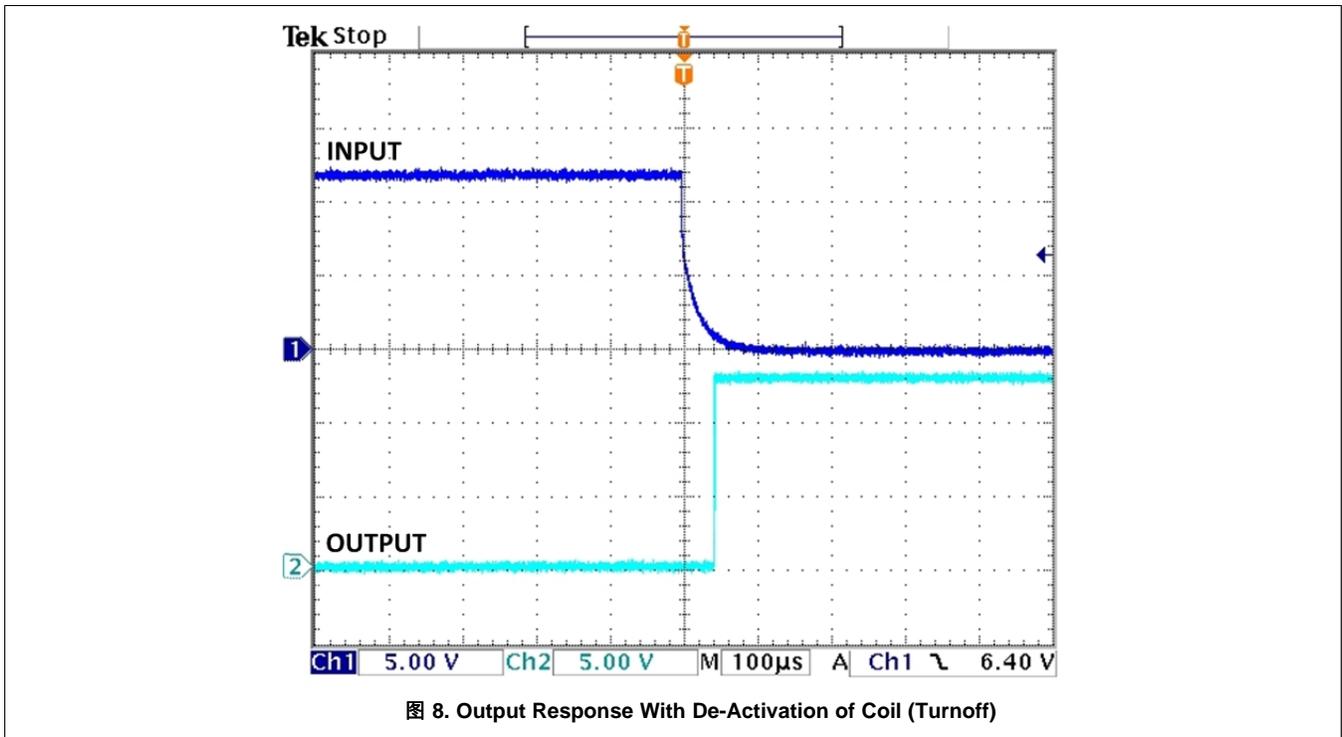
$$I_{COIL} = (V_{SUP} - V_{OL}) / R_{COIL} \quad (2)$$

8.2.2.5 Output Low Voltage

The output low voltage (V_{OL}) is drain to source (V_{DS}) voltage of the output NMOS transistors when the input is driven high and it is sinking current and can be determined by the [Electrical Characteristics](#) section or [图 1](#).

8.2.3 Application Curve

图 8 was generated with TPL7407LA-Q1 driving an OMRON G5NB relay -- $V_{in} = 5\text{ V}$; $V_{sup} = 12\text{ V}$ & $R_{COIL} = 2.8\text{ k}\Omega$



9 Power Supply Recommendations

The COM pin is the power supply pin of this device to power the gate drive circuitry. While a bypass capacitor on this pin is recommended for sensitive power supplies, it is not required for proper operation of the device. The COM pin supply ensures full drive potential with any GPIO above 1.5 V. The gate drive circuitry is based on low voltage CMOS transistors that can only handle a max gate voltage of 7 V. An integrated LDO reduces the COM voltage of 6.5 V to 30 V to a regulated voltage of 5.3 V. Though 6.5 V minimum is recommended for V_{COM} , the part still functions with a reduced COM voltage that has a reduced gate drive voltage and a resulting higher R_{dson} .

10 Layout

10.1 Layout Guidelines

Thin traces can be used on the input due to the low current logic that is typically used to drive the TPL7407LA-Q1. Care must be taken to separate the input channels as much as possible, as to eliminate cross-talk. Thick traces are recommended for the output, in order to drive whatever high currents that may be needed. Wire thickness can be determined by the trace material's current density and desired drive current.

Since all of the channels currents return to a common ground, it is best to size that trace width to be very wide. Some applications require up to 2 A.

Since the COM pin only draws up to 30 μ A, thick traces are not necessary.

10.2 Layout Example

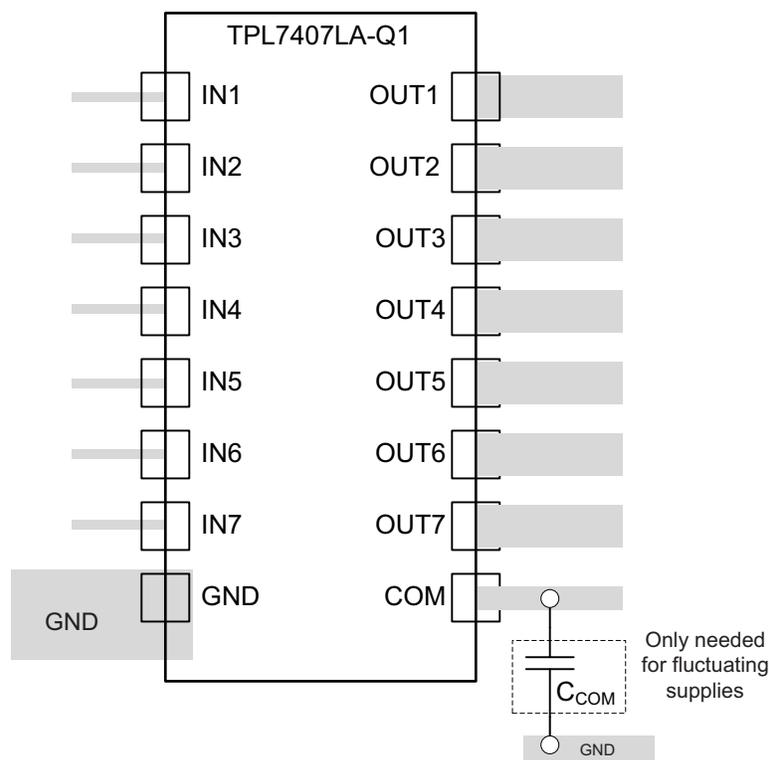


图 9. Package Layout

10.3 Thermal Considerations

The number of coils driven is dependent on the coil current and on-chip power dissipation. The number of coils driven can be determined by 图 3 or 图 4.

Thermal Considerations (接下页)

For a more accurate determination of number of coils possible, use [公式 3](#) to calculate TPL7407LA-Q1 on-chip power dissipation P_D :

$$P_D = \sum_{i=1}^N V_{OLi} \times I_{Li}$$

where

- N is the number of channels active together
- V_{OLi} is the OUT_i pin voltage for the load current I_{Li} . This is the same as $V_{CE(SAT)}$ (3)

In order to guarantee reliability of TPL7407LA-Q1 and the system, the on-chip power dissipation must be lower than or equal to the maximum allowable power dissipation ($P_{D(MAX)}$) dictated by below equation [公式 4](#).

$$P_{D(MAX)} = \frac{(T_{J(MAX)} - T_A)}{\theta_{JA}}$$

where

- $T_{J(MAX)}$ is the target maximum junction temperature
- T_A is the operating ambient temperature
- θ_{JA} is the package junction to ambient thermal resistance (4)

It is recommended to limit the TPL7407LA-Q1 IC's die junction temperature to less than 125°C. The IC junction temperature is directly proportional to the on-chip power dissipation.

10.3.1 Improving Package Thermal Performance

θ_{JA} value depends on the PC board layout. An external heat sink and/or a cooling mechanism, like a cold air fan, can help reduce θ_{JA} and thus improve device thermal capabilities. Refer to TI's design support web page at www.ti.com/thermal for a general guidance on improving device thermal performance.

11 器件和文档支持

11.1 接收文档更新通知

要接收文档更新通知，请导航至 TI.com.cn 上的器件产品文件夹。单击右上角的 [通知我](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

11.2 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [《使用条款》](#)。

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设计支持 [TI 参考设计支持](#) 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

11.3 商标

E2E is a trademark of Texas Instruments.

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11.4 静电放电警告



ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

11.5 术语表

[SLYZ022](#) — *TI 术语表*。

这份术语表列出并解释术语、缩写和定义。

12 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此产品说明书的浏览器版本，请查看左侧的导航栏。

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPL7407LAQPWRQ1	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	TPL747LAQ	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

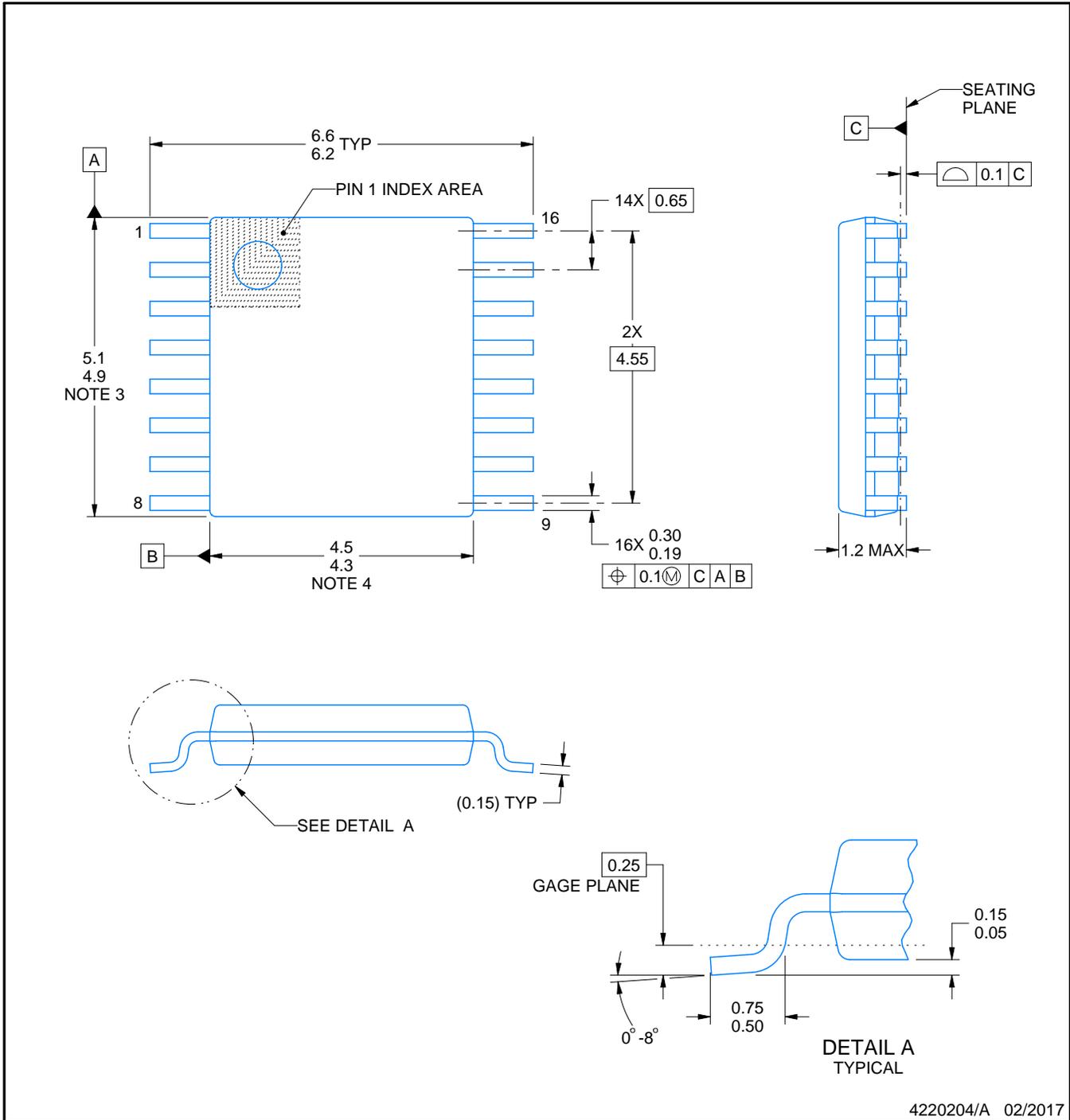
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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NOTES:

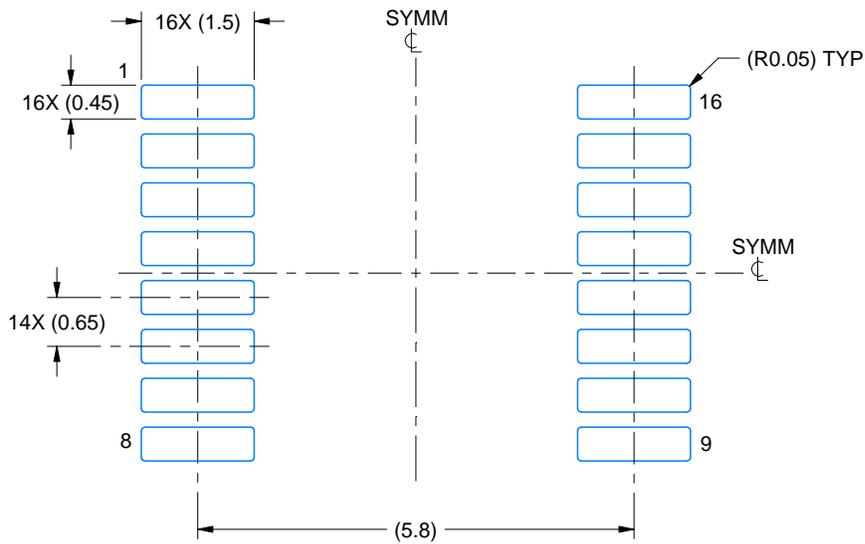
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

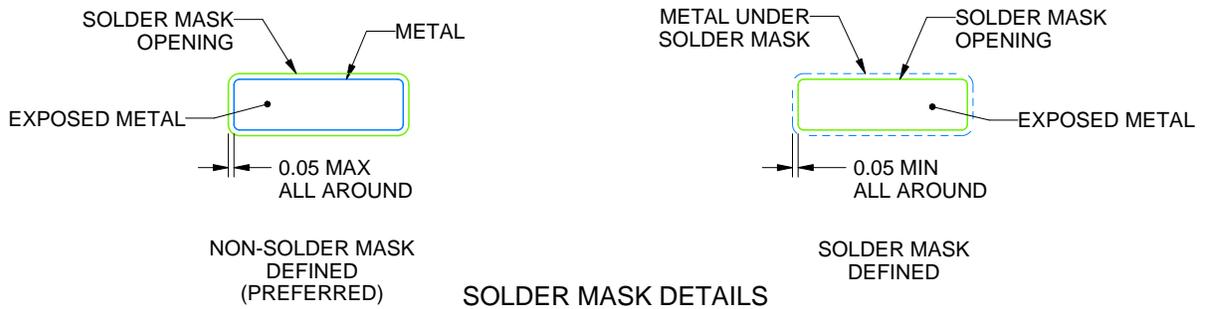
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

4220204/A 02/2017

NOTES: (continued)

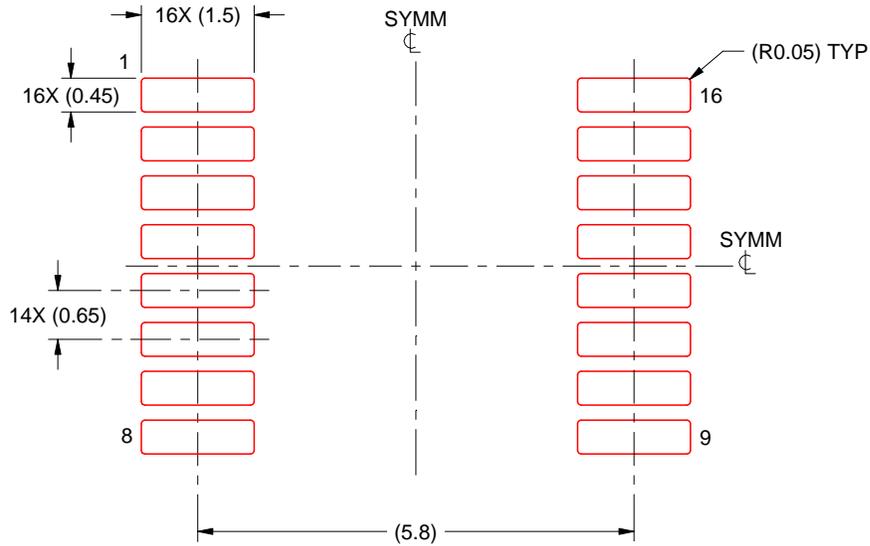
- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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